

SHEET 1 OF 1

INFORMATION DISCLOSURE
CITATION IN AN
APPLICATION

(PTO-1449)

ATTY. DOCKET NO.
067161-0135SERIAL NO.
10/757,438APPLICANT
Seiichi ENDO, et al.FILING DATE
January 15, 2004GROUP
2818

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US			
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FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code ¹ -Number + Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
						Yes	No
MM		EP 0 776 049 B1	05/28/1997	PROGRAMMABLE MICROELECTRONIC S CORPORATION		X	
MM		GB 2 363 679 A	01/02/2002	LUCENT TECHNOLOGIES INC.		X	
MM		EP 0 756 328 B1	01/15/2003	MOTOROLA INC.		X	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

EXAMINER

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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.



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<i>mm</i>		US 5,841,165	11/24/1998	Chang et al.	
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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)




EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.

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INFORMATION DISCLOSURE CITATION IN AN APPLICATION				ATTY. DOCKET NO. 67161-135		SERIAL NO. 10/757438		
(PTO-1449)				APPLICANT Seichi ENDO, et al.				
				FILING DATE January 15, 2004		GROUP 2800		
U.S. PATENT DOCUMENTS								
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear			
		US 5,886,378	03/23/1999	Wang	(Counterpart of JP 8-506693)			
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FOREIGN PATENT DOCUMENTS								
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code ² - Number - Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation		
						Yes	No	
		JP 8-506693	07/16/1996	LATTICE SEMICONDUCTOR CORPORATION		JAPAN (w/English Abstract) (Corresponds with US 5,886,378)		
		JP 3-57280	03/12/1991	MITSUBISHI ELECTRIC CORP.		JAPAN (w/English Abstract)		
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)								
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EXAMINER 				DATE CONSIDERED 6-9-05				

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